

#### **High Reliability Serial EEPROMs**

## WL-CSP EEPROM family SPI BUS



BU9832GUL-W No.10001EAT16

#### Description

BU9832GUL-W is a serial EEPROM of SPI BUS interface method.

#### Features

- 1) High speed clock action up to 5MHz (Max.)
- 2) Wait function by HOLD terminal.
- 3) Part or whole of memory arrays settable as read only memory area by program.
- 4) 1.8 ~ 5.5V single power source action most suitable for battery use.
- 5) Page write mode useful for initial value write at factory shipment.
- 6) For SPI bus interface (CPOL, CPHA) = (0, 0), (1, 1)
- 7) Auto erase and auto end function at data rewrite.
- 8) Low current consumption

At write action (5V) : 1.5mA (Typ.)At read action (5V) : 1.0mA (Typ.)At standby action (5V)  $: 0.1\mu A (Typ.)$ 

- 9) Address auto increment function at read action
- 10) Write mistake prevention function

Write prohibition at power on.

Write prohibition by command code (WRDI).

Write prohibition by WP pin.

Write prohibition block setting by status registers (BP1, BP0)

Write mistake prevention function at low voltage.

- 11) Data at shipment Memory array: FFh, status register WPEN, BP1, BP0: 0
- 12) Data kept for 40 years.
- 13) Data rewrite up to 1,000,000times.

#### ●Page write

Product number	Number of pages
BU9832GUL-W	32 Byte

#### ●BU9832GUL-W

Туре	Capacity	Bit format	Power source voltage	Package
BU9832GUL-W	8Kbit	1K×8	1.8~5.5V	VCSP50L2

#### ■Absolute maximum ratings (Ta=25°C)

Soldto maximum ratings (18-20 0)							
Parameter	Symbol	Ratings	Unit				
Impressed voltage	Vcc	-0.3~+6.5	V				
Permissible dissipation	Pd	220(VCSP50L2) *1	mW				
Storage Temperature range	Tstg	-65~+125	°C				
Operating Temperature range	Topr	-40~+85	°C				
Terminal voltage	_	-0.3~Vcc+0.3	V				

<sup>\*1</sup> When using at Ta=25°C or higher, 220mW to be reduced per 1°C

#### Recommended action conditions

Parameter	Symbol	Ratings	Unit
Power source voltage	Vcc	1.8~5.5	\/
Input voltage	Vin	0~Vcc	V

#### ● Memory cell characteristics (Ta=25°C, Vcc=1.8~5.5V)

Doromotor	Li	Unit		
Parameter	Min.	Тур.	Max	Unit
Number of data rewrite times *1	1,000,000	-	_	Times
Data hold years *1	40	_	_	Years

<sup>\*1 :</sup> Not 100% TESTED

#### ● Input / output capacity (Ta=25°C, frequency=5MHz)

Parameter	Symbol	Limits		Unit	Conditions
Farameter	Symbol	Min.	Max	Offic	Conditions
Input capacity *1	C <sub>IN</sub>	-	8	pF	V <sub>IN</sub> =GND
Output capacity *1	C <sub>OUT</sub>	-	8	pF	V <sub>OUT</sub> =GND

<sup>\*1 :</sup> Not 100% TESTED

#### ● Electrical characteristics (Unless otherwise specified, Ta=-40~+85°C, Vcc=1.8~5.5V)

Description (Clinical			Limits	10 100 0,		, Canditiana	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions	
"H" input voltage 1	VIH1	0.7xVcc	-	Vcc+0.3	V	1.8≦Vcc≦5.5V	
"L" input voltage 1	VIL1	-0.3	_	0.3xVcc	V	1.8≦Vcc≦5.5V	
"L" output voltage 1	VOL1	0	-	0.4	V	IOL=2.1mA(Vcc=2.5V~5.5V)	
"L" output voltage 2	VOL2	0	-	0.2	V	IOL=150μA(Vcc=1.8V~2.5V)	
"H" output voltage 1	VOH1	Vcc-0.5	_	Vcc	V	IOH=-0.4mA(Vcc=2.5V~5.5V)	
"H" output voltage 2	VOH2	Vcc-0.2	-	Vcc	V	IOH=-100μA(Vcc=1.8V~2.5V)	
Input leak current	ILI	-1	_	1	μΑ	VIN=0~Vcc	
Output leak current	ILO	-1	_	1	μΑ	VOUT=0~Vcc, CS =Vcc	
	ICC1	-	_	1.0	mA	Vcc=1.8V,fSCK=2MHz, tE/W=5ms Byte write, Page write, Write status register	
Current consumption at write action	ICC2	_	_	2.0	mA	Vcc=2.5V,fSCK=5MHz, tE/W=5ms Byte write, Page write, Write status register	
	ICC3	-	_	3.0	mA	Vcc=5.5V,fSCK=5MHz, tE/W=5ms Byte write, Page write, Write status register	
Current consumption	ICC4	-	-	1.5	mA	Vcc=2.5V,fSCK=5MHz Read, Read status register	
at read action	action ICC5 – 2.0 mA		mA	Vcc=5.5V,fSCK=5MHzN Read, Read status register			
Standby current	ISB	_	-	2	μA	Vcc=5.5V SCK=SI=Vcc or=GND,SO=OPEN	

OThis product is not designed for protection against radioactive rays.

#### Operating timing characteristics

(Ta=-40~+85°C, unless otherwise specified, load capacity C<sub>L1</sub>=100pF)

Parameter	Symbol	1.8≤Vcc<2.5V			2.5≤Vcc<5.5V			Unit
Farameter	Symbol	Min.	Тур.	Max.	Min.	Тур.	Max.	Offic
SCK frequency	fSCK	_	_	2	_	_	5	MH z
SCK high time	tSCKWH	200	_	_	85	_	-	ns
SCK low time	tSCKWL	200	_	_	85	_	-	ns
CS high time	tCS	200	_	_	85	_	-	ns
CS setup time	tCSS	200	_	_	90	_	-	ns
CS hold time	tCSH	200	_	_	85	_	_	ns
SCK setup time	tSCKS	200	_	_	90	_	-	ns
SCK hold time	tSCKH	200	_	_	90	_	-	ns
SI setup time	tDIS	40	_	_	20	_	-	ns
SI hold time	tDIH	50	_	_	40	_	_	ns
Data output delay time1	tPD1	_	_	150	_	_	70	ns
Data output delay time2 (C <sub>L2</sub> =30pF)	tPD2	_	_	145	_	_	55	ns
Output hold time	tOH	0	_	_	0	_	-	ns
Output disable time	tOZ	_	_	250	_	_	100	ns
HOLD setting setup time	tHFS	120	_	_	60	_	_	ns
HOLD setting hold time	tHFH	90	_	_	40	_	-	ns
HOLD release setup time	tHRS	120	_	_	60	_	-	ns
HOLD release hold time	tHRH	140	_	_	70	_	-	ns
Time from HOLD to output High-Z	tHOZ	_	_	250	_	_	100	ns
Time from HOLD To output change	tHPD	_	_	150	_	_	70	ns
SCK rise time	tRC	_	_	1	_	_	1	μs
SCK fall time *1	tFC	_	_	1	-	_	1	μs
Output rise time *1	tRO	_	_	100	-	_	50	ns
Output fall time *1	tFO	_	_	100	-	_	50	ns
Write time	tE/W	_	_	5	_	_	5	ms

<sup>\*1</sup> NOT 100% TESTED

#### ●AC measurement conditions

Parameter	Cymphol		Unit			
Falametei	Symbol	Min.	Тур.	Max.	Offic	
Load capacity 1	C <sub>L1</sub>	_	_	100	pF	
Load capacity 2	C <sub>L2</sub>	_	_	30	pF	
Input rise time	_	_	_	50	ns	
Input fall time	_	_	_	50	ns	
Input voltage	_	0.2Vcc/0.8Vcc		V		
Input / Output judgment voltage	_	0.3Vcc/0.7Vcc			V	

#### Sync data input / output timing

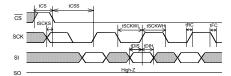


Fig.1 Input timing

SI is taken into IC inside in sync with data rise edge of SCK. IInput address and data from the most significant bit MSB.

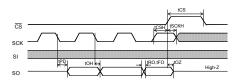


Fig.2 Input / Output timing

 ${\sf SO}$  is output in sync with data fall edge of SCK. Data is output from the most significant bit MSB.

# SCK SI Dn+1 High-Z High-Z Dn Dn-1 High-Z High-Z Dn Dn-1

Fig.3 HOLD timing

#### Block diagram

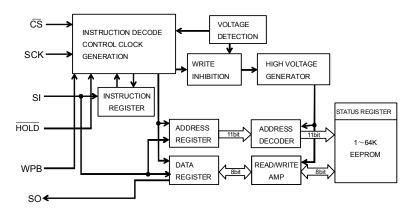


Fig.4 Block diagram

#### Pin assignment and description

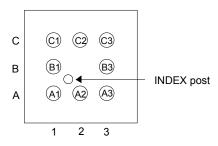
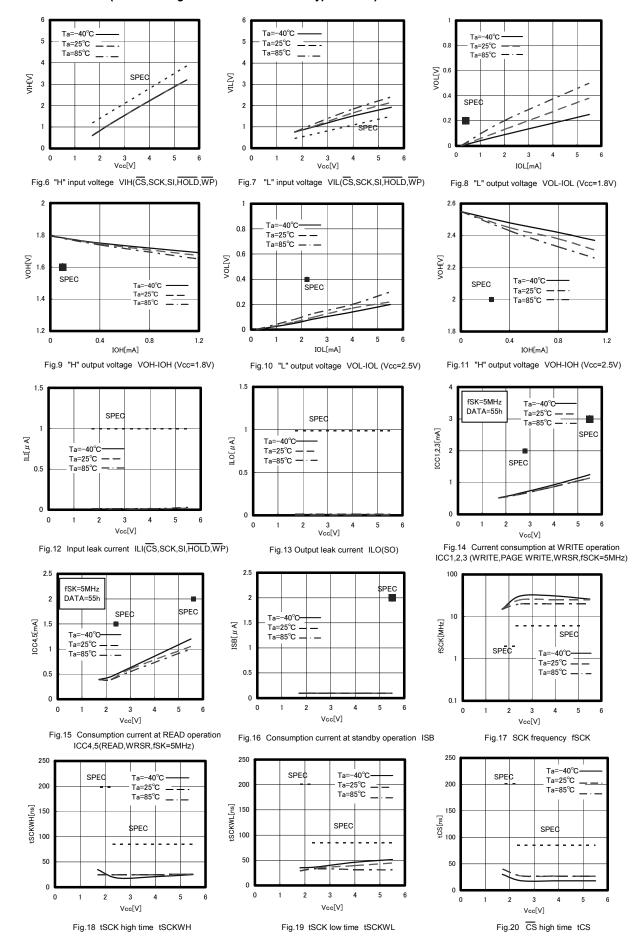


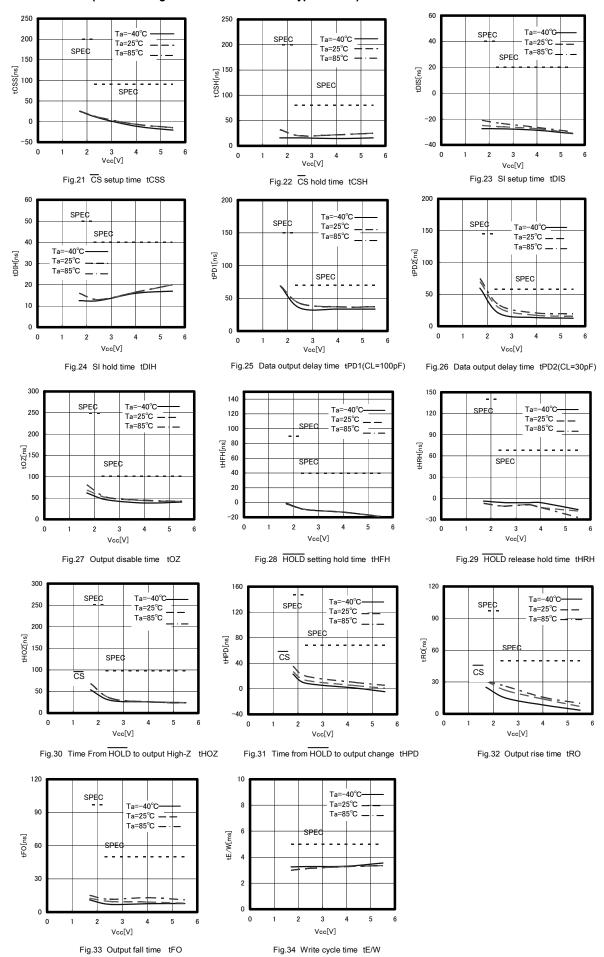
Fig.5 Pin assignment diagram

Land No.	Terminal name	Input/ Output	Function
A1	WPB	Input	Write protect input Write status register command is prohibited.
A2	GND	-	All input / output reference voltage, 0V
А3	SI	Input	Start bit, ope code, address, and serial data input
B1	so	Output	Serial data output
В3	SCK	Input	Serial clock input
C1	CS	Input	Chip select input
C2	Vcc	_	Power source to be connected
C3	HOLD	Input	Hold input Command communication may be suspended temporarily (HOLD status)

#### ● Characteristic data (The following characteristic data are Typ. Values.)



#### ● Characteristic data (The following characteristic data are Typ. Values.)



#### Features

#### OStatus registers

This IC has status registers. The status registers are of 8 bits and express the following parameters.

BP0 and BP1 can be set by write status register command. These 2 bits are memorized into the EEPROM, therefore are valid even when power source is turned off.

Rewrite characteristics and data hold time are same as characteristics of the EEPROM.

WEN can be set by write enable command and write disable command. WEN becomes write disable status when power source is turned off. R/B is for write confirmation, therefore cannot be set externally.

The value of status register can be read by read status command.

#### Status registers

Product number	bit 7	bit 6	bit 5	bit 4	bit 3	bit 2	bit 1	bit 0
BU9832GUL-W	WPEN	0	0	0	BP1	BP0	WEN	_ R/B

bit	Memory location	Function	Contents
WPEN	EEPROM	WP pin enable / disable designation bit WPEN=0=invalid WPEN=1=valid	This enables / disables the functions of $\overline{\text{WP}}$ pin.
BP1 BP0	EEPROM	EEPROM write disable block designation bit	This designates the write disable area of EEPROM. Write designation areas of product numbers are shown below.
WEN	Register	Write and write status register write enable / disable status confirmation bit WEN=0=prohibited WEN=1=permitted	
_ R/B	Register	Write cycle status (READY / BUSY) status confirmation bit $R/B = 0 = READY$ $R/B = 1 = BUSY$	

#### Write disable block setting

•	nto diodbio biook cotting					
	BP1	BP0	Write disable block			
	0	0	None			
	0	1	300h-3FFh			
	1	0	200h-3FFh			
	1	1	000h-3FFh			

#### O WP pin

By setting  $\overline{WP}$  =LOW, write command is prohibited. As for BU9832GUL-W when WPEN bit is set "1", the  $\overline{WP}$  pin functions become valid. And the write command to be disabled at this moment is WRSR.

However, when write cycle is in execution, no interruption can be made.

Product number	WRSR	WRITE
BU9832GUL-W	Prohibition possible but WPEN bit "1"	Prohibition impossible

#### OHOLD pin

By  $\overline{\text{HOLD}}$  pin, data transfer can be interrupted. When SCK="1", by making  $\overline{\text{HOLD}}$  from "1" into"0", data transfer to EEPROM is interrupted. When SCK = "0", by making  $\overline{\text{HOLD}}$  from "0" into "1", data transfer is restarted.

#### ■Command mode

Command		Contents	Ope code	
WREN	Write enable	Write enable command	0000	0110
WRDI	Write disable	Write disable command	0000	0100
READ	Read	Read command	0000	0011
WRITE	Write	Write command	0000	0010
RDSR	Read status register	Status register read command	0000	0101
WRSR	Write status register	Status register write command	0000	0001

#### Timing chart

- 1. Write enable (WREN) / disable (WRDI) cycle
  - WREN (WRITE ENABLE): Write enable

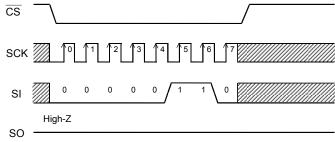


Fig.35 Write enable command

· WRDI (WRITE DISABLE): Write disable

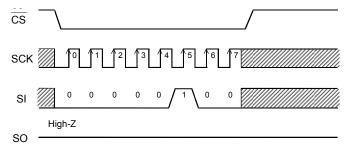


Fig.36 Write disable

OThis IC has write enable status and write disable status. It is set to write enable status by write enable command, and it is set to write disable status by write disable command. As for these commands, set  $\overline{CS}$  LOW, and then input the respective ope codes. The respective commands accept command at the 7-th clock rise. Even with input over 7 clocks, command becomes valid.

When to carry out write and write status register command, it is necessary to set write enable status by the write enable command. If write or write status register command is input in the write disable status, commands are cancelled. And even in the write enable status, once write and write status register command is executed once, it gets in the write disable status. After power on, this IC is in write disable status.

#### 2. Read command (READ)

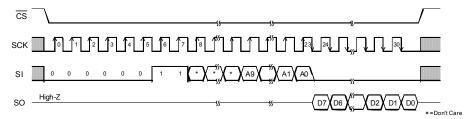


Fig.37 Read command

By read command, data of EEPROM can be read. As for this command, set  $\overline{CS}$  LOW, then input address after read ope code. EEPROM starts data output of the designated address. Data output is started from SCK fall of 15 clock, and from D7 to D0 sequentially. This IC has increment read function. After output of data for 1 byte (8bits), by continuing input of SCK, data of the next address can be read. Increment read can read all the addresses of EEPROM. After reading data of the most significant address, by continuing increment read, data of the most insignificant address is read.

#### 3. Write command (WRITE)

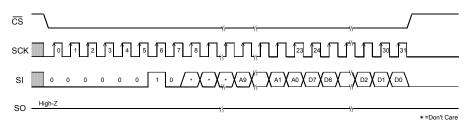


Fig.38 Write command

By write command, data of EEPROM can be written. As for this command, set  $\overline{CS}$  LOW, then input address and data after write ope code. Then, by making  $\overline{CS}$  HIGH, the EEPROM starts writing. The write time of EEPROM requires time of tE/W (Max 5ms). During tE/W, other than status read command is not accepted. Start  $\overline{CS}$  after taking the last data (D0), and before the next SCK clock starts. At other timing, write command is not executed, and this write command is cancelled. This IC has page write function, and after input of data for 1 byte (8 bits), by continuing data input without starting  $\overline{CS}$ , data up to 16 bytes can be written for one tE/W. In page write, the insignificant 4 bit of the designated address is incremented internally at every time when data of 1 byte is input and data is written to respective addresses. When data of the maximum bytes or higher is input, address rolls over, and previously input data is overwritten.

9/18

#### 4. Status register write / read command

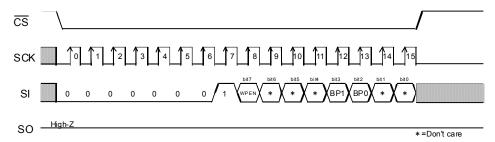


Fig.39 Status register write command

Write status register command can write status register data. The data can be written by this command are 2 bits 1, that is, BP1 (bit3) and BP0 (bit2) among 8 bits of status register. By BP1 and BP0, write disable block of EEPROM can be set. As for this command, set  $\overline{CS}$  LOW, and input ope code of write status register, and input data. Then, by making  $\overline{CS}$  HIGH, EEPROM starts writing. Write time requires time of tE/W as same as write. As for  $\overline{CS}$  rise, start  $\overline{CS}$  after taking the last data bit (bit0), and before the next SCK clock starts. At other timing, command is cancelled. Write disable block is determined by BP1 and BP0, and the block can be selected from 1/4 of memory array, 1/2, and entire memory array. (Refer to the write disable block setting table.) To the write disabled block, write cannot be made, and only read can be made.

3bits including 1WPEN (bit7)

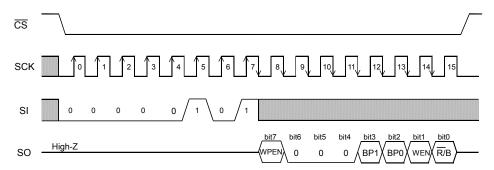


Fig.40 Status register read command

#### At standby

OCurrent at standby

Set  $\overline{\text{CS}}$  "H", and be sure to set SCK, SI,  $\overline{\text{WP}}$ ,  $\overline{\text{HOLD}}$  input "L" or "H". Do not input intermediate electric potantial. OTiming

As shown in Fig.41, at standby, when SCK is "H", even if  $\overline{CS}$  is fallen, SI status is not read at fall edge. SI status is read at SCK rise edge after fall of  $\overline{CS}$ . At standby and at power ON/OFF, set  $\overline{CS}$  "H" status.

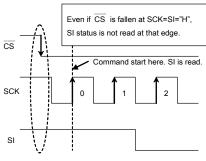


Fig.41 Operating timing

#### ● WP cancel valid area

 $\overline{\text{WP}}$  is normally fixed to "H" or "L" for use, but when  $\overline{\text{WP}}$  is controlled so as to cancel write status register command and write command, pay attention to the following  $\overline{\text{WP}}$  valid timing.

While write or write status register command is executed, by setting  $\overline{WP}$  = "L" in cancel valid area, command can be cancelled. The area from command ope code before  $\overline{CS}$  rise at internal automatic write start becomes the cancel valid area. However, once write is started, any input cannot be cancelled.  $\overline{WP}$  input becomes Don't Care, and cancellation becomes invalid.

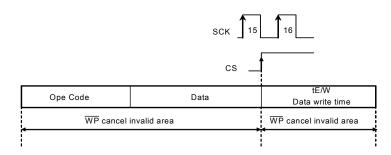


Fig.42 WP valid timing (WRSR)



Fig.43 WP valid timing (WRITE)

#### ● HOLD pin

By HOLD pin, command communication can be stopped temporarily (HOLD status). The HOLD pin carries out command communications normally when it is HIGH. To get in HOLD status, at command communication, when SCK=LOW, set the HOLD pin LOW. At HOLD status, SCK and SI become Don't Care, and SO becomes high impedance (High-Z). To release the HOLD status, set the HOLD pin HIGH when SCK=LOW. After that, communication can be restarted from the point before the HOLD status. For example, when HOLD status is made after A5 address input at read, after release of HOLD status, by starting A4 address input, read can be restarted. When in HOLD status, leave  $\overline{CS}$  LOW. When it is set  $\overline{CS}$  =HIGH in HOLD status, the IC is reset, therefore communication after that cannot be restarted.

#### Method to cancel each command

#### **OREAD**

**ORDSR** 

• Method to cancel : cancel by  $\overline{\text{CS}}$  = "H"

• Method to cancel : cancel by  $\overline{CS}$  = "H"

## Ope code Address Data 8 bits 8 bits 8 bits Cancel available in all areas of read mode

Fig.44 READ cancel valid timing

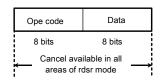


Fig.45 RDSR cancel valid timing

### OWRITE, PAGE WRITE

- a: Ope code, address input area.

  Cancellation is available by  $\overline{\text{CS}}$  ="H"
- b: Data input area (D7~D1 input area)
  Cancellation is available by CS ="H"
- c: Data input area (D0 area)

When  $\overline{CS}$  is started, write starts.

After  $\overline{CS}$  rise, cancellation cannot be made by any means.

d: tE/W area.

Cancellation is available by  $\overline{CS}$  = "H". However, when write starts ( $\overline{CS}$  is started) in the area c, cancellation cannot be made by any means. And by inputting on SCK clock, cancellation cannot be made. In page write mode, there is write enable area at every 8 clocks.

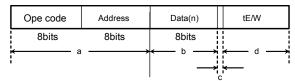
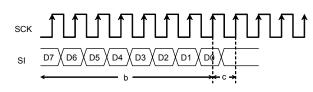


Fig.46 WRITE cancel valid timing



- Note 1) If Vcc is made OFF during write execution, designated address data is not guaranteed, therefore write it once again.
- Note 2) If CS is started at the same timing as that of the SCK rise, write execution / cancel becomes unstable, therefore, it is necessary to fall in SCK = "L" area. As for SCK rise, assure timing of tCSS / tCSH or higher.

#### **OWRSR**

a: From ope code to 15 rise.

Cancel by CS ="H".

b: From 15 clock rise to 16 clock rise (write enable area).

When  $\overline{CS}$  is started, write starts.

After  $\overline{CS}$  rise, cancellation cannot be made by any means.

c: After 16 clock rise.

Cancel by  $\overline{CS}$  ="H". However, when write starts ( $\overline{CS}$  is started) in the area b, cancellation cannot be made by any means.

And, by inputting on SCK clock, cancellation cannot be made.

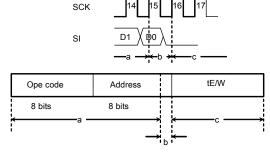


Fig.47 WRSR cancel valid timing

- Note 1) If Vcc is made OFF during write execution, designated address data is not guaranteed, therefore write it once again
- Note 2) If  $\overline{CS}$  is started at the same timing as that of the SCK rise, write execution / cancel becomes unstable, therefore, it is necessary to fall in SCK = "L" area. As for SCK rise, assure timing of tCSS / tCSH or higher.

#### OWREN/WRDI

- a: From ope code to clock rise, cancel by  $\overline{CS} = "H"$ .
- b: Cancellation is not available when CS is started after 7 clock.

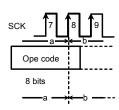


Fig.48 WREN/WRDI cancel valid timing

#### High speed operation

In order to realize stable high speed operations, pay attention to the following input / output pin conditions.

Olnput pin pull up, pull down resistance

When to attach pull up, pull down resistance to EEPROM input pin, select an appropriate value for the microcontroller  $V_{OL}$ ,  $I_{OL}$  from  $V_{IL}$  characteristics of this IC.

#### OPull up resistance

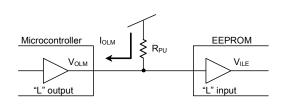


Fig.49 Pull up resistance

$$R_{PU} \ge \frac{V_{CC}-V_{OLM}}{I_{OLM}} \cdots 1$$
 $V_{OLM} \le V_{ILE} \cdots 2$ 

Example) When Vcc=5V,  $V_{ILM}$ =1.5V,  $V_{OLM}$ =0.4V,  $I_{OLM}$ =2mA, from the equation ①,

$$R_{PU} \geq \frac{5-0.4}{2 \times 10^{-3}}$$

$$\therefore R_{PU} \geq 2.3[k\Omega]$$

With the value of  $R_{PU}$  to satisfy the above equation,  $V_{OLM}$  becomes 0.4V or higher, and with  $V_{ILE}$  (=1.5V), the equation ② is also satisfied.

- V<sub>ILM</sub> :EEPROM V<sub>IH</sub> specifications
- V<sub>OLM</sub>: Microcontroller V<sub>OL</sub> specifications
- I<sub>OLM</sub>: Microcontroller I<sub>OL</sub> specifications

And, in order to prevent malfunction, mistake write at power ON/OFF, be sure to make  $\overline{\text{CS}}$  pull up.

#### OPull down resistance

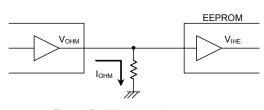


Fig.50 Pull down resistance

$$R_{PD} \geq \frac{V_{OHM}}{I_{OHM}} \cdots 3$$
 $V_{OHM} \geq V_{IHE} \cdots 4$ 

Example) When  $V_{CC}$ =5V,  $V_{OHM}$ = $V_{CC}$ -0.5V,  $I_{OHM}$ =0.4mA,  $V_{IHM}$ = $V_{CC}$ ×0.7V, from the equation③,

$$R_{PD} \geq \frac{5 \cdot 0.5}{0.4 \times 10^{\cdot 3}}$$

$$\therefore R_{PU} \geq 11.3[k\Omega]$$

Further, by amplitude VIHE, VILE of signal input to EEPROM, operation speed changes. By inputting signal of amplitude of  $V_{CC}$  / GND level to input, more stable high speed operations can be realized. On the contrary, when amplitude of  $0.8V_{CC}$  /  $0.2V_{CC}$  is input, operation speed becomes slow.

In order to realize more stable high speed operation, it is recommended to make the values of  $R_{PU}$ ,  $R_{PD}$  as large as possible, and make the amplitude of signal input to EEPROM close to the amplitude of  $V_{CC}$  / GND level. (\*1 At this moment, operating timing guaranteed value is guaranteed.)

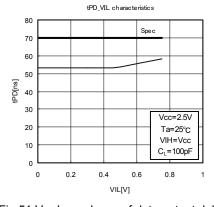


Fig.51  $V_{\text{IL}}$  dependency of data output delay time

#### OSO load capacity condition

Load capacity of SO output pin affects upon delay characteristic of SO output. (Data output delay time, time from  $\overline{\text{HOLD}}$  to High-Z) In order to make output delay characteristic into higher speed, make SO load capacity small. In concrete, "Do not connect many devices to SO bus", "Make the wire between the controller and EEPROM short", and so forth.

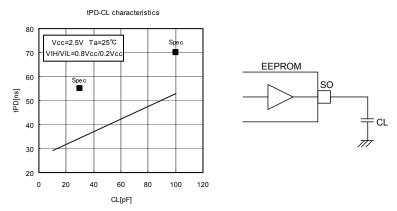


Fig.52 SO load dependency of data output delay time

#### OOther cautions

Make the wire length from the microcontroller to EEPROM input signal same length, in order to prevent setup / hold violation to EEPROM, owing to difference of wire length of each input.

#### ●Equivalent circuit

OOutput circuit

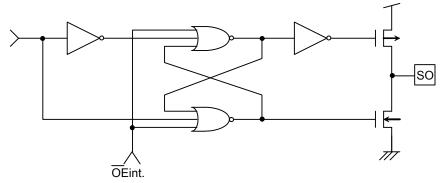


Fig.53 SO output equivalent circuit

#### Olnput circuit

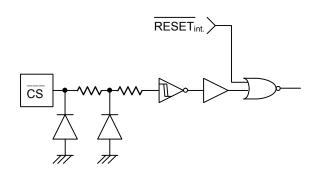


Fig.54 CS input equivalent circuit

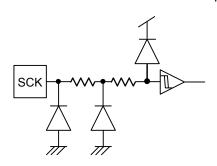


Fig.55 SCK input equivalent circuit

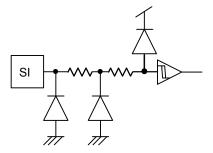


Fig.56 SI input equivalent circuit

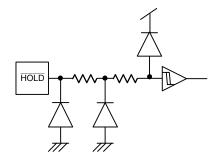


Fig.57 HOLD input equivalent circuit

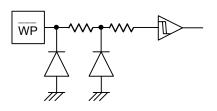


Fig.58 WP input equivalent circuit

#### ●Notes on power ON/OFF

OAt power ON/OFF, set  $\overline{CS}$  "H" (=Vcc).

When  $\overline{CS}$  is "L", this IC gets in input accept status (active). If power is turned on in this status, noises and the likes may cause malfunction, mistake write or so. To prevent these, at power ON, set  $\overline{CS}$  "H". (When  $\overline{CS}$  is in "H" status, all inputs are canceled.)

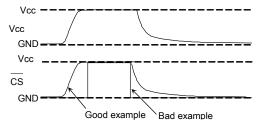


Fig.59 CS timing at power ON/OFF

(Good example)  $\overline{\text{CS}}$  terminal is pulled up to Vcc.

At power OFF, take 10ms or higher before supply. If power is turned on without observing this condition,

the IC internal circuit may not be reset, which please note.

(Bad example) CS terminal is "L" at power ON/OFF.

In this case, CS always becomes "L" (active status), and EEPROM may have malfunction, mistake write owing to noises and the likes.

Even when  $\overline{\text{CS}}$  input is High-Z, the status becomes like this case, which please note.

#### OP.O.R. circuit

This IC has a P.O.R. (Power On Reset) circuit as mistake write countermeasure. After P.O.R. action, it gets in write disable status. The P.O.R. circuit is valid only when power is ON, and does not work when power is OFF. When power is ON, if the recommended conditions of the following tR, tOFF, and Vbot are not satisfied, it may become write enable status owing to noises and the likes.

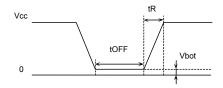


Fig.60 Rise waveform

Recommended conditions of t <sub>R</sub> , t <sub>OFF</sub> , Vbot						
t <sub>R</sub>	t <sub>OFF</sub>	Vbot				
10ms or below	10ms or higher	0.3V or below				
100ms or below	10ms or higher	0.2V or below				

#### Noise countermeasures

#### OVcc noise (bypass capacitor)

When noise or surge gets in the power source line, malfunction may occur, therefore, for removing these, it is recommended to attach a bypass capacitor (0.1µF) between IC Vcc and GND. At that moment, attach it as close to IC as possible. And, it is also recommended to attach a bypass capacitor between board Vcc and GND.

#### OSCK noise

When the rise time (tR) of SCK is long, and a certain degree or more of noise exists, malfunction may occur owing to clock bit displacement. To avoid this, a Schmitt trigger circuit is built in SCK input. The hysterisis width of this circuit is set about 0.2V, if noises exist at SCK input, set the noise amplitude 0.2Vp-p or below. And it is recommended to set the rise time (tR) of SCK 100ns or below. In the case when the rise time is 100ns or higher, take sufficient noise countermeasures. Make the clock rise, fall time as small as possible.

#### OWP noise

During execution of write status register command, if there exist noises on  $\overline{WP}$  pin, mistake in recognition may occur and forcible cancellation may result, which please note. To avoid this, a Schmitt trigger circuit is built in  $\overline{WP}$  input. In the same manner, a Schmitt trigger circuit is built in SI input, SI input and  $\overline{HOLD}$  input too.

#### Notes for use

- (1) Described numeric values and data are design representative values, and the values are not guaranteed.
- (2) We believe that application circuit examples are recommendable, however, in actual use, confirm characteristics further sufficiently. In the case of use by changing the fixed number of external parts, make your decision with sufficient margin in consideration of static characteristics and transition characteristics and fluctuations of external parts and our LSI.
- (3) Absolute maximum ratings

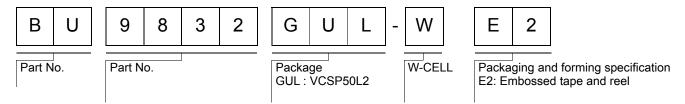
If the absolute maximum ratings such as impressed voltage and operating temperature range and so forth are exceeded, LSI may be destructed. Do not impress voltage and temperature exceeding the absolute maximum ratings. In the case of fear exceeding the absolute maximum ratings, take physical safety countermeasures such as fuses, and see to it that conditions exceeding the absolute maximum ratings should not be impressed to LSI.

- (4) GND electric potential
  - Set the voltage of GND terminal lowest at any action condition. Make sure that each terminal voltage is higher than that of GND terminal.
- (5) Heat design

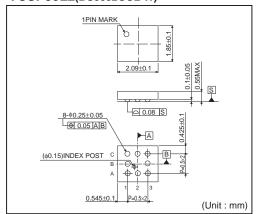
In consideration of permissible dissipation in actual use condition, carry out heat design with sufficient margin.

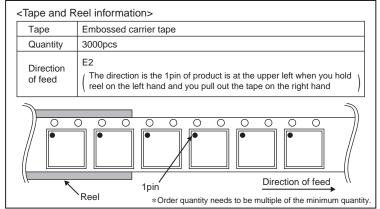
- (6) Terminal to terminal short circuit and wrong packaging When to package LSI onto a board, pay sufficient attention to LSI direction and displacement. Wrong packaging may destruct LSI. And in the case of short circuit between LSI terminals and terminals and power source, terminal and GND owing to foreign matter, LSI may be destructed.
- (7) Use in a strong electromagnetic field may cause malfunction, therefore, evaluate design sufficiently.

#### Ordering part number



#### VCSP50L2(BU9832GUL-W)





#### Notes

No copying or reproduction of this document, in part or in whole, is permitted without the consent of ROHM Co.,Ltd.

The content specified herein is subject to change for improvement without notice.

The content specified herein is for the purpose of introducing ROHM's products (hereinafter "Products"). If you wish to use any such Product, please be sure to refer to the specifications, which can be obtained from ROHM upon request.

Examples of application circuits, circuit constants and any other information contained herein illustrate the standard usage and operations of the Products. The peripheral conditions must be taken into account when designing circuits for mass production.

Great care was taken in ensuring the accuracy of the information specified in this document. However, should you incur any damage arising from any inaccuracy or misprint of such information, ROHM shall bear no responsibility for such damage.

The technical information specified herein is intended only to show the typical functions of and examples of application circuits for the Products. ROHM does not grant you, explicitly or implicitly, any license to use or exercise intellectual property or other rights held by ROHM and other parties. ROHM shall bear no responsibility whatsoever for any dispute arising from the use of such technical information.

The Products specified in this document are intended to be used with general-use electronic equipment or devices (such as audio visual equipment, office-automation equipment, communication devices, electronic appliances and amusement devices).

The Products specified in this document are not designed to be radiation tolerant.

While ROHM always makes efforts to enhance the quality and reliability of its Products, a Product may fail or malfunction for a variety of reasons.

Please be sure to implement in your equipment using the Products safety measures to guard against the possibility of physical injury, fire or any other damage caused in the event of the failure of any Product, such as derating, redundancy, fire control and fail-safe designs. ROHM shall bear no responsibility whatsoever for your use of any Product outside of the prescribed scope or not in accordance with the instruction manual.

The Products are not designed or manufactured to be used with any equipment, device or system which requires an extremely high level of reliability the failure or malfunction of which may result in a direct threat to human life or create a risk of human injury (such as a medical instrument, transportation equipment, aerospace machinery, nuclear-reactor controller, fuel-controller or other safety device). ROHM shall bear no responsibility in any way for use of any of the Products for the above special purposes. If a Product is intended to be used for any such special purpose, please contact a ROHM sales representative before purchasing.

If you intend to export or ship overseas any Product or technology specified herein that may be controlled under the Foreign Exchange and the Foreign Trade Law, you will be required to obtain a license or permit under the Law.



Thank you for your accessing to ROHM product informations. More detail product informations and catalogs are available, please contact us.

#### ROHM Customer Support System

http://www.rohm.com/contact/